

FIG. 4

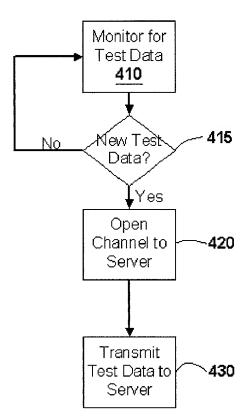


FIG. 5

Analyzer Usage		Date Range:	<u>Jan 1, 2001 - Jan 7, 2001</u>
	<u>Location</u>	Serial#	# Tests Run
	ATG	134	12
		234	17
		345	23
		456	90
	внм	98	77
		67	79
		4567	87
		45	92
	CAE	1234	101
	GSP	2342	77
		23454	92
		3453	99

Date Range: Jan 1, 2001 - Jan 7, 2001	cturerModelTest Name# Failures# Times Test Run3SAT freq2226Up speed1626ST deviation1226	6150 Up speed 22 SAT freq 16 ST deviation 12	2112 Up speed 44 SAT freq 23
Failure by Model	<u>Manufacturer</u> Motorola		Nokia

Failures by Analyzer Date		SAT freq			Up Speed		
Range:	Serial #	1234	45234	2452454	234545	24543	2452454
Date Range: Jan 1, 2001 - Jan 7, 2001	# Failures	22	16	12	22	16	12
Jan 7, 2001	# Failures # Times Test Run	26	26	26	26	26	26

185 285
Up speed ST deviation Up speed SAT freq ST deviation
Nokia